## NVMYS014N06CL

## MOSFET－Power，Single N－Channel

60 V， $15 \mathrm{~m} \Omega, 37$ A

## Features

－Small Footprint（ $5 \times 6 \mathrm{~mm}$ ）for Compact Design
－Low $\mathrm{R}_{\mathrm{DS}(\text { on）}}$ to Minimize Conduction Losses
－Low $\mathrm{Q}_{\mathrm{G}}$ and Capacitance to Minimize Driver Losses
－LFPAK4 Package，Industry Standard
－AEC－Q101 Qualified and PPAP Capable
－These Devices are $\mathrm{Pb}-$ Free and are RoHS Compliant

MAXIMUM RATINGS $\left(T_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise noted）

| Parameter |  |  | Symbol | Value | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| Drain－to－Source Voltage |  |  | $V_{\text {DSS }}$ | 60 | V |
| Gate－to－Source Voltage |  |  | $V_{G S}$ | $\pm 20$ | V |
| Continuous Drain Current $\mathrm{R}_{\text {日JC }}$ （Notes 1，2，3） | Steady State | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{I}_{\mathrm{D}}$ | 36 | A |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 21 |  |
| Power Dissipation <br> $\mathrm{R}_{\text {өJC }}$（Notes 1，2） |  | $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 37 | W |
|  |  | $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ |  | 12 |  |
| Continuous Drain Current $\mathrm{R}_{\theta \mathrm{JA}}$ （Notes 1，2，3） | Steady State | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | $\mathrm{I}_{\mathrm{D}}$ | 12 | A |
|  |  | $\mathrm{T}_{\mathrm{A}}=100^{\circ} \mathrm{C}$ |  | 8.4 |  |
| Power Dissipation $\mathrm{R}_{\theta \mathrm{JA}}$（Notes 1 \＆2） |  | $\mathrm{T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$ | $\mathrm{P}_{\mathrm{D}}$ | 3.8 | W |
|  |  | $\mathrm{T}_{\mathrm{A}}=100^{\circ} \mathrm{C}$ |  | 1.9 |  |
| Pulsed Drain Current | $\mathrm{T}_{\mathrm{A}}=2$ | $\mathrm{C}, \mathrm{t}_{\mathrm{p}}=10 \mu \mathrm{~s}$ | IDM | 185 | A |
| Operating Junction and Storage Temperature |  |  | $\mathrm{T}_{\mathrm{J}}, \mathrm{T}_{\text {stg }}$ | $\begin{gathered} -55 \text { to } \\ +175 \end{gathered}$ | ${ }^{\circ} \mathrm{C}$ |
| Source Current（Body Diode） |  |  | Is | 31 | A |
| Single Pulse Drain－to－Source Avalanche Energy（ $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}, \mathrm{I}_{\mathrm{L}(\mathrm{pk})}=1.6 \mathrm{~A}$ ） |  |  | $\mathrm{E}_{\text {AS }}$ | 65 | mJ |
| Lead Temperature for Soldering Purposes （ $1 / 8^{\prime \prime}$ from case for 10 s ） |  |  | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device．If any of these limits are exceeded，device functionality should not be assumed，damage may occur and reliability may be affected．

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
| :--- | :---: | :---: | :---: |
| Junction－to－Case－Steady State | $\mathrm{R}_{\text {日JC }}$ | 4.1 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| Junction－to－Ambient－Steady State（Note 2） | $\mathrm{R}_{\text {日JA }}$ | 39 |  |

1．The entire application environment impacts the thermal resistance values shown， they are not constants and are only valid for the particular conditions noted．
2．Surface－mounted on FR4 board using a $650 \mathrm{~mm}^{2}, 2 \mathrm{oz}$ ．Cu pad．
3．Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle．

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www．onsemi．com

| $\mathbf{V}_{\text {（BR）DSS }}$ | $\mathbf{R}_{\text {DS（ON）}}$ MAX | $\mathbf{I}_{\mathrm{D}}$ MAX |
| :---: | :---: | :---: |
| 60 V | $15 \mathrm{~m} \Omega @ 10 \mathrm{~V}$ | 37 A |
|  | $21.5 \mathrm{~m} \Omega @ 4.5 \mathrm{~V}$ |  |

G（4）


N－CHANNEL MOSFET

| LFPAK4 |
| :--- | :--- |
| CASE 760AB |

## ORDERING INFORMATION

See detailed ordering，marking and shipping information on page 5 of this data sheet．

## NVMYS014N06CL

ELECTRICAL CHARACTERISTICS $\left(\mathrm{T}_{J}=25^{\circ} \mathrm{C}\right.$ unless otherwise specified)

| Parameter | Symbol | Test Condition |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| OFF CHARACTERISTICS |  |  |  |  |  |  |  |
| Drain-to-Source Breakdown Voltage | $\mathrm{V}_{\text {(BR) }}$ DSS | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=250 \mu \mathrm{~A}$ |  | 60 |  |  | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | $\mathrm{V}_{(\mathrm{BR})_{\mathrm{T}} \mathrm{DSS}}$ |  |  |  | 26 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| Zero Gate Voltage Drain Current | IDSs | $V_{G S}=0 \mathrm{~V},$ | $\mathrm{T}_{J}=25^{\circ} \mathrm{C}$ |  |  | 10 | $\mu \mathrm{A}$ |
|  |  |  | $\mathrm{T}_{J}=125^{\circ} \mathrm{C}$ |  |  | 250 |  |
| Gate-to-Source Leakage Current | $\mathrm{I}_{\text {GSS }}$ | $\mathrm{V}_{\mathrm{DS}}=0 \mathrm{~V}$ | 20 V |  |  | 100 | nA |

ON CHARACTERISTICS (Note 4)

| Gate Threshold Voltage | $\mathrm{V}_{\mathrm{GS}(\mathrm{TH})}$ | $\mathrm{V}_{\mathrm{GS}}=\mathrm{V}_{\mathrm{DS}}, \mathrm{I}_{\mathrm{D}}=25 \mu \mathrm{~A}$ |  | 1.2 |  | 2.0 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Negative Threshold Temperature Coefficient | $\mathrm{V}_{\mathrm{GS}(\mathrm{TH})} / \mathrm{T}_{\mathrm{J}}$ |  |  |  | -5.0 |  | $\mathrm{mV} /{ }^{\circ} \mathrm{C}$ |
| Drain-to-Source On Resistance | $\mathrm{R}_{\mathrm{DS} \text { (on) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ |  | 12.5 | 15 | $\mathrm{m} \Omega$ |
|  |  | $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}$ | $\mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ |  | 17.9 | 21.5 |  |
| Forward Transconductance | $\mathrm{g}_{\text {FS }}$ | $\mathrm{V}_{\mathrm{DS}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=15 \mathrm{~A}$ |  |  | 43 |  | S |

CHARGES, CAPACITANCES \& GATE RESISTANCE

| Input Capacitance | $\mathrm{C}_{\text {ISS }}$ | $\mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{f}=1 \mathrm{MHz}, \mathrm{V}_{\mathrm{DS}}=25 \mathrm{~V}$ | 620 | pF |
| :---: | :---: | :---: | :---: | :---: |
| Output Capacitance | Coss |  | 340 |  |
| Reverse Transfer Capacitance | $\mathrm{C}_{\text {RSS }}$ |  | 7.0 |  |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{G}(\text { (TOT) }}$ | $\mathrm{V}_{\mathrm{GS}}=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=48 \mathrm{~V} ; \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ | 4.5 | nC |
| Total Gate Charge | $\mathrm{Q}_{\mathrm{G}(\text { (TOT) }}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=48 \mathrm{~V} ; \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ | 9.7 |  |
| Threshold Gate Charge | $\mathrm{Q}_{\mathrm{G}(\mathrm{TH})}$ | $\mathrm{V}_{\mathrm{GS}}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=48 \mathrm{~V} ; \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}$ | 1.3 |  |
| Gate-to-Source Charge | $Q_{G S}$ |  | 2.1 |  |
| Gate-to-Drain Charge | $Q_{\text {GD }}$ |  | 1.0 |  |
| Plateau Voltage | $\mathrm{V}_{\mathrm{GP}}$ |  | 3.1 | V |

SWITCHING CHARACTERISTICS (Note 5)

| Turn-On Delay Time | $\mathrm{t}_{\mathrm{d}(\mathrm{ON})}$ | $\begin{gathered} V_{G S}=10 \mathrm{~V}, \mathrm{~V}_{\mathrm{DS}}=48 \mathrm{~V}, \\ \mathrm{I}_{\mathrm{D}}=10 \mathrm{~A}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega \end{gathered}$ | 7.0 | ns |
| :---: | :---: | :---: | :---: | :---: |
| Rise Time | $\mathrm{t}_{\mathrm{r}}$ |  | 13 |  |
| Turn-Off Delay Time | $\mathrm{t}_{\mathrm{d} \text { (OFF) }}$ |  | 25 |  |
| Fall Time | $\mathrm{t}_{\mathrm{f}}$ |  | 6.0 |  |

DRAIN-SOURCE DIODE CHARACTERISTICS

| Forward Diode Voltage | $\mathrm{V}_{\text {SD }}$ | $\begin{aligned} & \hline \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \\ & \mathrm{I}_{\mathrm{S}}=10 \mathrm{~A} \end{aligned}$ | $\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}$ | 0.85 | 1.2 | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | $\mathrm{T}_{\mathrm{J}}=125^{\circ} \mathrm{C}$ | 0.72 |  |  |
| Reverse Recovery Time | $\mathrm{t}_{\mathrm{RR}}$ | $\begin{gathered} \mathrm{V}_{\mathrm{GS}}=0 \mathrm{~V}, \mathrm{dIS} / \mathrm{dtt}=20 \mathrm{~A} / \mathrm{\mu s}, \\ \mathrm{I}_{\mathrm{S}}=10 \mathrm{~A} \end{gathered}$ |  | 23.8 |  | ns |
| Charge Time | $\mathrm{t}_{\mathrm{a}}$ |  |  | 11.9 |  |  |
| Discharge Time | $\mathrm{t}_{\mathrm{b}}$ |  |  | 11.8 |  |  |
| Reverse Recovery Charge | $\mathrm{Q}_{\mathrm{RR}}$ |  |  | 11.6 |  | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Pulse Test: pulse width $\leq 300 \mu \mathrm{~s}$, duty cycle $\leq 2 \%$.
5. Switching characteristics are independent of operating junction temperatures.

## NVMYS014N06CL

## TYPICAL CHARACTERISTICS



Figure 1. On-Region Characteristics


Figure 3. On-Resistance vs. Gate-to-Source Voltage


Figure 5. On-Resistance Variation with Temperature


Figure 2. Transfer Characteristics


Figure 4. On-Resistance vs. Drain Current and Gate Voltage


Figure 6. Drain-to-Source Leakage Current vs. Voltage

## NVMYS014N06CL

## TYPICAL CHARACTERISTICS



Figure 7. Capacitance Variation


Figure 9. Resistive Switching Time Variation vs. Gate Resistance


Figure 11. Maximum Rated Forward Biased Safe Operating Area


Figure 8. Gate-to-Source vs. Total Charge


Figure 10. Diode Forward Voltage vs. Current


Figure 12. IPEAK vs. Time in Avalanche

## NVMYS014N06CL

## TYPICAL CHARACTERISTICS



Figure 13. Thermal Characteristics
DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping $^{\dagger}$ |
| :---: | :---: | :---: | :---: |
| NVMYS014N06CLTWG | 014N06CL | LFPAK4 | $3000 /$ Tape \& Reel |
|  | (Pb-Free) |  |  |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

LFPAK4 5x6
CASE 760AB
ISSUE C
DATE 19 NOV 2019



SIDE VIEW



BOTTOM VIEW

RECOMMENDED LAND PATTERN
*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.


| XXXXXX | $=$ Specific Device Code |
| :--- | :--- |
| A | $=$ Assembly Location |
| WL | Wafer Lot |
| Y | = Year |
| W | Work Week |

*This information is generic. Please refer to device data sheet for actual part marking. Some products may not follow the Generic Marking

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| DESCRIPTION: | LFPAK45x6 | PAGE 1 OF 1 |

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